

<b>Notice of References Cited</b>	Application/Control No. 09/944,488	Applicant(s)/Patent Under Reexamination FARNWORTH, WARREN M.	
	Examiner Emmanuel S. Luk	Art Unit 1722	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,985,185	11-1999	Steijer et al.	264/1.7
	B	US-6,193,493 B1	02-2001	Steijer et al.	425/116
	C	US-6,280,661 B1	08-2001	Takakuwa et al.	264/1.33
	D	US-6,482,576 B1	11-2002	Farnworth et al.	430/322
	E	US-6,562,272 B1	05-2003	Chang et al.	264/272.14
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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